

# Product data sheet

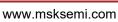
www.msksemi.com

#### Schematic diagram

Compiance

MS50N06

Semiconductor

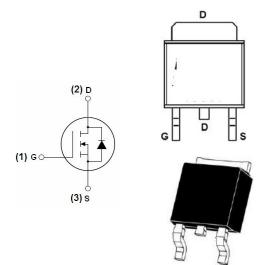


### FEATURE

- High density cell design for ultra low R<sub>dson</sub>
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E<sub>AS</sub>
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

#### APPLICATION

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



TO-252

Parameter	Symbol	Value	Unit	
Drain-Source Voltage	V <sub>DS</sub>	60	- v	
Gate-Source Voltage	V <sub>GS</sub>	±20		
Continuous Drain Current	ID	50		
Pulsed Drain Current	I <sub>DM</sub>	220	A	
Single Pulsed Avalanche Energy*	E <sub>AS</sub>	115	mJ	
Power Dissipation	PD	1.25	W	
Thermal Resistance from Junction to Ambient	R <sub>0JA</sub>	100	°C/W	
Junction Temperature	TJ	150	- °C	
Storage Temperature	T <sub>stg</sub>	-50 ~+150		

#### Maximum ratings (T<sub>a</sub>=25°C unless otherwise noted)

\*E<sub>AS</sub> condition:  $T_j=25^{\circ}C$ ,  $V_{DD}=50V$ , L=0.5mH,  $R_G=25\Omega$ , Starting  $T_J = 25^{\circ}C$ 





#### Electrical characteristics (Ta=25°C unless otherwise noted)

Parameter	Symbol	<b>Test Condition</b>	Min	Тур	Max	Unit
Off characteristics				-11		
Drain-source breakdown voltage	V(BR) DSS	Vgs = 0V, Id =250µA	60			V
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V			1	μA
Gate-body leakage current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
On characteristics (note1)						
Gate-threshold voltage	VGS(th)	VDS =VGS, ID =250µA	1.5		2.5	V
Static drain-source on-resistance	RDS(on)	Vgs =10V, Id =20A		11.5	15	mΩ
Forward transconductance	$g_{\text{FS}}$	VDS =25V, ID =20A	24			S
Dynamic characteristics (note 2)		1		-1 1		
Input capacitance	C <sub>iss</sub>			900		pF
Output capacitance	Coss	Vbs =25V,Vgs =0V, f =1MHz		104		
Reverse transfer capacitance	C <sub>rss</sub>			33		
Switching characteristics (note 2)	-	1				
Total gate charge	Qg	V <sub>DS</sub> =30V, V <sub>GS</sub> =10V, In=50A		30		nC
Gate-source charge	Q <sub>gs</sub>			10		
Gate-drain charge	Q <sub>gd</sub>			5		
Turn-on delay time	t <sub>d(on)</sub>	N 001/1 04		25		
Turn-on rise time	tr	V <sub>DD</sub> =30V,ID=2A, V <sub>GS</sub> =10V,R <sub>G</sub> =2.5Ω, R <sub>L</sub> =15Ω		5		- ns
Turn-off delay time	td(off)			50		
Turn-off fall time	tr	- 1002		6		
Drain-Source Diode Characteristics		1	I			
Drain-source diode forward voltage(note1)	V <sub>SD</sub>	Vgs =0V, Is=40A			1.2	V
Continuous drain-source diode forward current	Is				50	A
Pulsed drain-source diode forward current	I <sub>SM</sub>				220	Α

Notes:

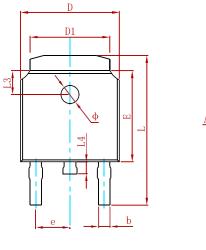
1. Pulse Test : Pulse Width $\leq$ 300µs, duty cycle $\leq$ 2%.

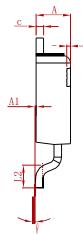
2. Guaranteed by design, not subject to production.



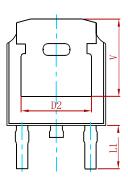


# PACKAGE MECHANICAL DATA



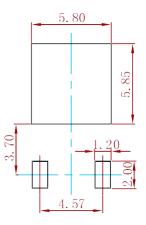


h



0. maked	Dimensions	In Millimeters	Dimensions In Inches			
Symbol	Min.	Max.	Min.	Max.		
A	2.200	2.400	0.087	0.094		
A1	0.000	0.127	0.000	0.005		
b	0.635	0.770	0.025	0.030		
С	0.460	0.580	0.018	0.023		
D	6.500	6.700	0.256	0.264		
D1	5.100	5.460	0.201	0.215		
D2	4.830	4.830 REF.		0.190 REF.		
E	6.000	6.200	0.236	0.244		
e	2.186	2.386	0.086	0.094		
L	9.712	10.312	0.382	0.406		
L1	2.900 REF.		0.114 REF.			
L2	1.400	1.700	0.055	0.067		
L3	1.600 REF.		0.063 REF.			
L4	0.600	1.000	0.024	0.039		
Φ	1.100	1.300	0.043	0.051		
θ	0°	8°	0°	8°		
h	0.000	0.300	0.000	0.012		
V	5.250 REF.		0.207 REF.			

## Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm

3. The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

P/N	PKG	QTY
MS50N06	TO-252	2500



# <u>Attention</u>

■ Any and all MSKSEMI Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your MSKSEMI Semiconductor representative nearest you before using any MSKSEMI Semiconductor products described or contained herein in such applications.

MSKSEMI Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any andall MSKSEMI Semiconductor products described orcontained herein.

■ Specifications of any and all MSKSEMI Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.

■ MSKSEMI Semiconductor. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with someprobability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits anderror prevention circuits for safedesign, redundant design, and structural design.

■ In the event that any or all MSKSEMI Semiconductor products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from theauthorities concerned in accordance with the above law.

■ No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of MSKSEMI Semiconductor.

■ Information (including circuit diagrams and circuit parameters) herein is for example only ; it is not guaranteed for volume production. MSKSEMI Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.

 Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. Whendesigning equipment, refer to the "Delivery Specification" for the MSKSEMI Semiconductor productthat you intend to use.

# **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by MSKSEMI manufacturer:

Other Similar products are found below :

614233C 648584F IRFD120 IRFF430 JANTX2N5237 2N7000 FCA20N60\_F109 FDZ595PZ AOD464 2SK2267(Q) 2SK2545(Q,T) 405094E 423220D MIC4420CM-TR VN1206L 614234A 715780A SSM6J414TU,LF(T 751625C BSC884N03MS G BSF024N03LT3 G PSMN4R2-30MLD TK31J60W5,S1VQ(O 2SK2614(TE16L1,Q) DMN1017UCP3-7 EFC2J004NUZTDG FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE2384 NTE2969 NTE6400A DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 SSM6P54TU,LF DMP22D4UFO-7B IPS60R3K4CEAKMA1 DMN1006UCA6-7 DMN16M9UCA6-7 STF5N65M6 STU5N65M6 C3M0021120D DMN13M9UCA6-7 BSS340NWH6327XTSA1 MCM3400A-TP DMTH10H4M6SPS-13 IRF40SC240ARMA1 IPS60R1K0PFD7SAKMA1